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	U	1	Document ID	Issue Date	Page s	Title	Current OR
1			US 4672559 A	19870609	16	Method for operating a microscopical mapping system	382/128
2			EP 186490 A	19860702	16	Flying field operation for microscopical mapping system - joystick controlled mapping leaves marks trail moving in unison with stage motion, to remain superimposed on viewed image	

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	Current XRef	Retrieva l Classif	Inventor	s	С	P	2	3	4	5
1	345/634; 345/781; 348/79; 358/1.18	1	Jansson, Peter A. et al.	⊠						
2			JANSSON, P A et al.							

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